Switching Transistor

NPN Silicon





MPS3646

MAXIMUM RATINGS

Rating Symbol Value Unit							
Symbol	Symbol Value						
VCEO	15	Vdc					
VCES	40	Vdc					
VCBO	40	Vdc					
VEBO	5.0	Vdc					
IC	300 500	mAdc					
PD	625 5.0	mW mW/°C					
PD	1.5 12	Watts mW/°C					
TJ, T _{Stg}	-55 to +150	°C					
	VCES VCBO VEBO IC PD PD	VCEO 15 VCES 40 VCBO 40 VEBO 5.0 IC 300 PD 625 5.0 5.0 PD 1.5 12 12					

THERMAL CHARACTERISTICS

Characteristic	Symbol	Max	Unit
Thermal Resistance, Junction to Ambient	$R_{ hetaJA}$	200	°C/W
Thermal Resistance, Junction to Case	$R_{ hetaJC}$	83.3	°C/W

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

Characteristic Min Max Unit Symbol **OFF CHARACTERISTICS** Collector-Emitter Breakdown Voltage 40 Vdc V(BR)CES $(I_C = 100 \ \mu Adc, \ V_{BE} = 0)$ Collector-Emitter Sustaining Voltage(1) VCEO(sus) 15 Vdc $(I_{C} = 10 \text{ mAdc}, I_{B} = 0)$ Collector-Base Breakdown Voltage Vdc V(BR)CBO 40 $(I_{C} = 100 \ \mu Adc, I_{F} = 0)$ Emitter-Base Breakdown Voltage 5.0 Vdc V(BR)EBO $(I_E = 100 \ \mu Adc, I_C = 0)$ **Collector Cutoff Current** μAdc ICES $(V_{CE} = 20 \text{ Vdc}, V_{BE} = 0)$ 0.5 $(V_{CE} = 20 \text{ Vdc}, V_{BE} = 0, T_A = 65^{\circ}\text{C})$ _ 3.0

1. Pulse Test: Pulse Width \leq 300 µs; Duty Cycle \leq 2.0%.

Preferred devices are Motorola recommended choices for future use and best overall value.



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ELECTRICAL CHARACTERISTICS ($T_A = 25^{\circ}C$ unless otherwise noted) (Continued)

	Symbol	Min	Max	Unit		
ON CHARACTERI	STICS(1)		•			
DC Current Gain		$(I_{C} = 30 \text{ mAdc}, V_{CE} = 0.4 \text{ Vdc})$ $(I_{C} = 100 \text{ mAdc}, V_{CE} = 0.5 \text{ Vdc})$ $(I_{C} = 300 \text{ mA}, V_{CE} = 1.0 \text{ Vdc})$	hFE	30 25 15	120 — —	-
Collector-Emitter Sa	aturation Voltage		V _{CE(sat)}	 	0.2 0.28 0.5 0.3	Vdc
Base-Emitter Satura	ation Voltage	$(I_{C} = 30 \text{ mAdc}, I_{B} = 3.0 \text{ mAdc})$ $(I_{C} = 100 \text{ mAdc}, I_{B} = 10 \text{ mAdc})$ $(I_{C} = 300 \text{ mAdc}, I_{B} = 30 \text{ mA})$	VBE(sat)	0.73 — —	0.95 1.2 1.7	Vdc
SMALL-SIGNAL (CHARACTERISTICS	3			•	
Current–Gain — Bandwidth Product (I _C = 30 mAdc, V _{CE} = 10 Vdc, f = 100 MHz)				350	—	MHz
Output Capacitance (V _{CB} = 5.0 Vdc, I _E = 0, f = 1.0 MHz)					5.0	pF
Input Capacitance (V _{EB} = 0.5 Vdc, I _C	c = 0, f = 1.0 MHz)	C _{ibo}	_	9.0	pF	
SWITCHING CHAF	RACTERISTICS		•			
Turn–On Time			ton	_	18	ns
Delay Time	(V _{CC} = 10 Vdc, I _C = (Figure 1)	= 300 mAdc, I _{B1} = 30 mAdc)	t _d	_	10	ns
Rise Time			t _r		15	ns
Turn–Off Time	(V _{CC} = 10 Vdc, I _C =	= 300 mAdc, I _{B1} = I _{B2} = 30 mAdc)	^t off		28	ns
Fall Time	(Figure 1)		t _f		15	ns
Storage Time (V _{CC} = 10 Vdc, I _C	; = 10 mAdc, I _{B1} = I _{B2}	t _s	—	18	ns	

1. Pulse Test: Pulse Width \leq 300 µs; Duty Cycle \leq 2.0%.

Test Condition	۱c	vcc	RS	RC	C _{S(max)}	V _{BE(off)}	V ₁	v ₂	V ₃
	mA	V	Ω	Ω	pF	V	V	V	V
Α	10	3	330	270	4	-1.5	10.55	-4.15	10.70
В	10	10	580	960	4	—	_	-4.65	6.55
С	100	10	560	96	12	-2.0	6.35	-4.65	6.55

Figure 1. Switching Time Equivalent Test Circuit



CURRENT GAIN CHARACTERISTICS









Figure 4. Turn–Off Waveform

NOTE 1

When a transistor is held in a conductive state by a base current, I_B, a charge, Q_S, is developed or "stored" in the transistor. Q_S may be written: $Q_S = Q_1 + Q_V + Q_X$.

 Q_1 is the charge required to develop the required collector current. This charge is primarily a function of alpha cutoff frequency. Q_V is the charge required to charge the collector–base feedback capacity. Q_X is excess charge resulting from overdrive, i.e., operation in saturation.

The charge required to turn a transistor "on" to the edge of saturation is the sum of Q₁ and Q_V which is defined as the active region charge, Q_A. Q_A = I_{B1tr} when the transistor is driven by a constant current step (I_{B1}) and I_{B1} < < $\frac{I_C}{h_{FF}}$.

If I_B were suddenly removed, the transistor would continue to conduct until Q_S is removed from the active regions through an external path or through internal recombination. Since the internal recombination time is long compared to the ultimate capability of a transistor, a charge, Q_T, of opposite polarity, equal in magnitude, can be stored on an external capacitor, C, to neutralize the internal charge and considerably reduce the turn–off time of the transistor. Figure 3 shows the test circuit and Figure 4 the turn–off waveform. Given Q_T from Figure 13, the external C for worst–case turn–off in any circuit is: $C = Q_T/\Delta V$, where ΔV is defined in Figure 3.

"ON" CONDITION CHARACTERISTICS



Figure 6. Saturation Voltage Limits

Figure 7. Temperature Coefficients

DYNAMIC CHARACTERISTICS



Figure 8. Delay Time



Figure 9. Rise Time



Figure 13. Maximum Charge Data

PACKAGE DIMENSIONS



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